

The Influence of Environment Temperature on the Degradation of Lead Zirconate Titanate Ceramic

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Keywords: Lead Zirconate Titanate (PZT) Ceramic, Degradation, Abnormal Fatigue.

Abstract. Lead zirconate titanate (PZT) ceramic, as a kind of piezoelectric material, is widely used in the field of electronic industry because of its excellent piezoelectric characteristics and low cost. Research works found that during the working time of the PZT ceramic, an electrical degradation phenomenon will occur that is represented as the decreasing of the electrical resistance and piezoelectric properties and the increasing of leakage current. When increase the temperature of the work environment, the lifetime of the piezoelectric ceramic will be dramatically shortened. This work proposes to analyze the influence of working temperature on the lifetime of piezoelectric ceramic by detecting the changes of leakage current of piezoelectric ceramics under different temperature. The study has important significance on solving the abnormal fatigue aging problem of piezoelectric ceramic in the different working environment.

Introduction

Lead zirconate titanate (PZT) piezoelectric ceramic is with electrical degradation under electric field. The leakage current of sample rises gradually and the resistance reduce. The influence of voltage, temperature and humidness on the degradation of PZT has been studied extensively. For example, E. Loh has considered the grain boundary model to explain the degradation. This theory holds the point that the direct reason of degradation is the crystal boundary's degradation because of the voltage (DC). J. Thongrueng et al proposed another theory of the metal ion's migration to explain the phenomenon of degradation and blackboard. But how the temperature dose influence on the PZT is not reported, this article designs a simple experiment to explain the influence of temperature on the PZT and provide us a method to predict the lifetime of PZT.

Experiment

This sample's formula is $\text{Pb}(\text{Zr}_{52}\text{Ti}_{48})\text{O}_3+0.1\text{wt}\%\text{K}+0.5\text{wt}\%\text{Cr}$, which is used in this experiment, and the sample's size is $20\text{mm}\times 5\text{mm}\times 0.15\text{mm}$. In order to get the expectant result, we designed the experiment terrace.

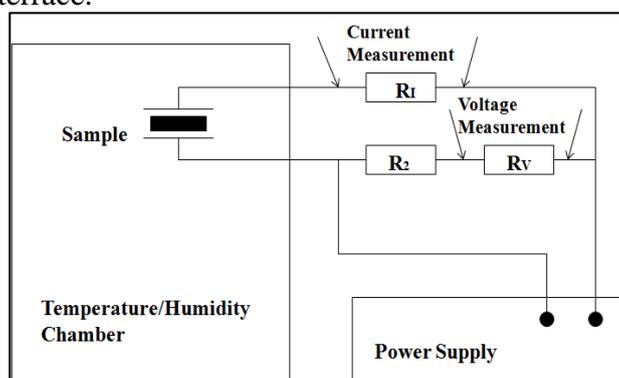


Fig. 1 The experiment terrace

The figure 1 is the experiment terrace. In the picture, the power supply provides steady voltage (230V). Because of the sample's resistance is greater than 10MΩ, but the series connection resistance is just 10kΩ, so the voltage of the sample is 230V approximate. In the experiment, the surroundings humidity is 90%RH, and the temperature is 50°C, 60°C and 70°C. We recorded the sample's leakage current and analyzed it as follows.

The Consequence and Analyses

In order to obtain the effect of the temperature on the electrical degradation of PZT, samples leakage current changing with the time at different temperature, “ Samples at different temperature resistance changing with the time ”,“ Through the sample leakage current reaches a certain value when the relationship between time and temperature” three fact to analysis.

Samples Leakage Current and Resistance Changing with the Time at Different Temperature

The electrical degradation rate under different environmental conditions of Lead zirconate titanate piezoelectric ceramic samples in different electrical shows as the Fig.2.

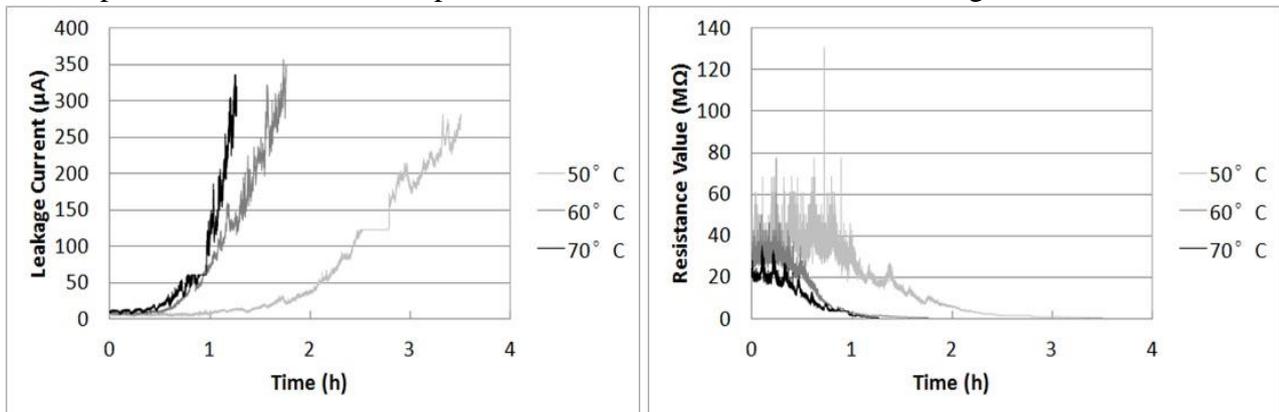


Fig.2 The relationship of resistance and leakage current of samples under different temperature and time

The Fig.2 shows that sample's leakage current and resistance changing with the time at the different temperature(50°C, 60°C, 70°C) when the humidity is 90%RH. From Fig. 2, Through the sample of the leakage current increases with the increase of temperature the speed was accelerated, when the temperature is 70°C, samples has the fastest electrical degradation rate. Electrical degradation rate of the slowest is under the condition of temperature of 50 °C, but from the fig.2, it can be obvious seen that when the temperature is 60, its electrical degradation rate is not the environment temperature of 50 °C and 70 °C under the condition of the average, Samples of the resistance with the temperature rise rate decreases, Reduce the rate increases with temperature, The sample resistance decreases with temperature increase rate was not present a linear trend.

Through the Sample Leakage Current Reaches a Certain Value when the Relationship between Time and Temperature

Collect the relevant 2 points, using the data analysis, Fitting by the leakage current of the sample at different values of the relationship between time and temperature. Shows in Fig.3.

Fig.3 fitted the leakage current of different values of the relationship between time and temperature. From the Fig.3, it can be seen that no matter what the samples electrical degradation to the leakage current of 150µA , 200µA or 250µA, the time(t) and temperature (T) are fitted below formula:

$$T = at^{\beta} \tag{1}$$

The leakage current reaches a certain value, based on the relationship between the time and temperature:

$$t = \left(\frac{T}{\alpha}\right)^{\frac{1}{\beta}} \quad (2)$$

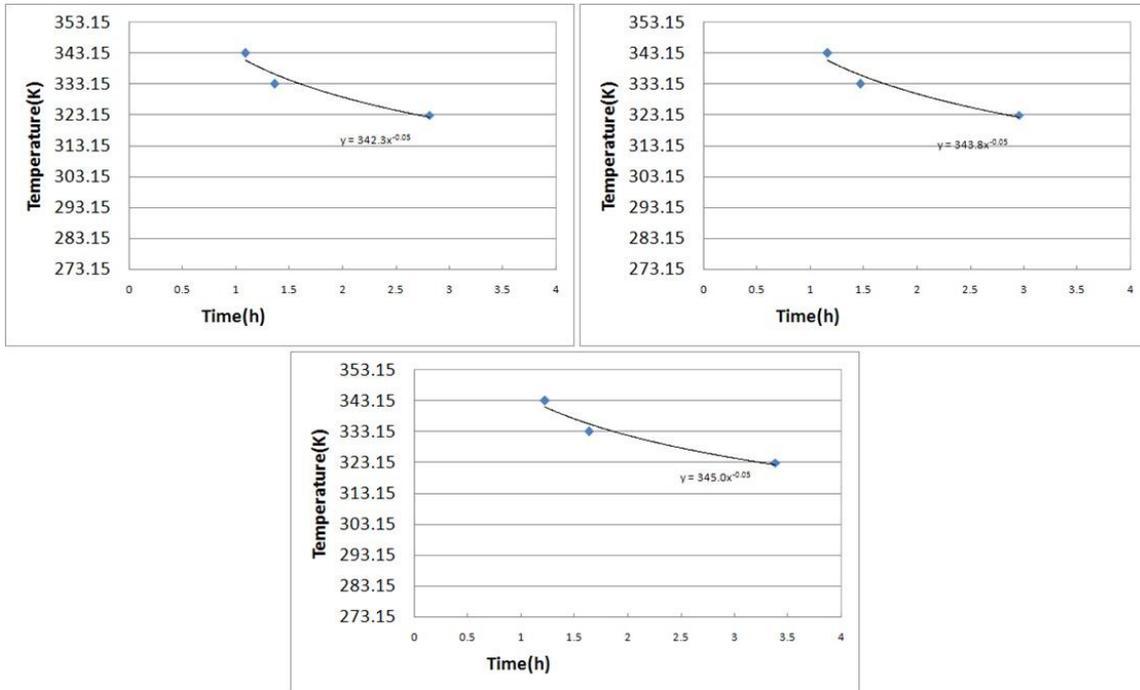


Fig.3 The relationship of time and temperature while the samples electrical degradation up to 150 μA, 200 μA and 250 μA

The α and β is constant in the formula, the α rises up gradually from 342.3K with the leakage current ($\geq 150 \mu A$). The β equals to -0.05. We matched the relationship of the α and the leakage current IL in the fig.4.

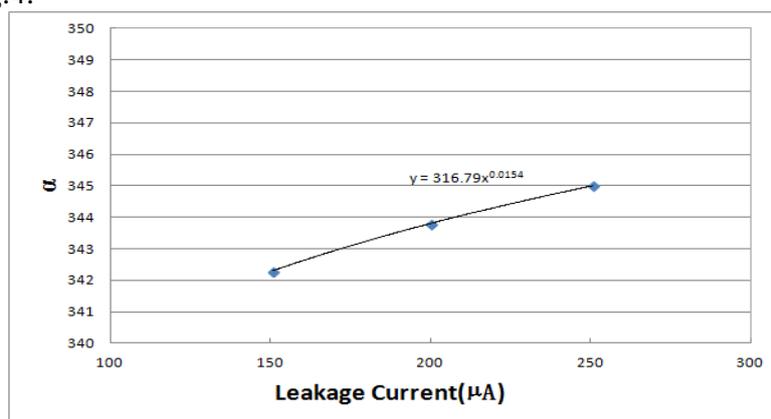


Fig.4 The relationship of the α and IL

In fig.4, we know:

$$\alpha = mI_L^n \quad (3)$$

And

$$t = \left(\frac{T}{mI_L^n}\right)^{\frac{1}{\beta}} = m^{-\frac{1}{\beta}} T^{-\frac{1}{\beta}} I_L^{-\frac{n}{\beta}} \quad (4)$$

$$-\frac{1}{\beta} = \gamma, \quad m^{-\frac{1}{\beta}} = C, \quad -\frac{n}{\beta} = \delta, \quad \text{so: } t = CT^\gamma I_L^\delta \quad (\gamma < 0, \quad |\gamma| > 1) \quad (5)$$

From the formula we can work out that the temperature is higher, the degradation rate is more quick. We can use this formula to compute the lifetime of the PZT while ascertain the leakage current I_L .

Experiment on the Relationship between Different Time Leakage Current and Temperature

Collect related point in the Fig.5, Fitting the experiment to the different time(0.25h, 0.5h, 1h), the relationship between leakage current and temperature through the sample, show as Fig.5.

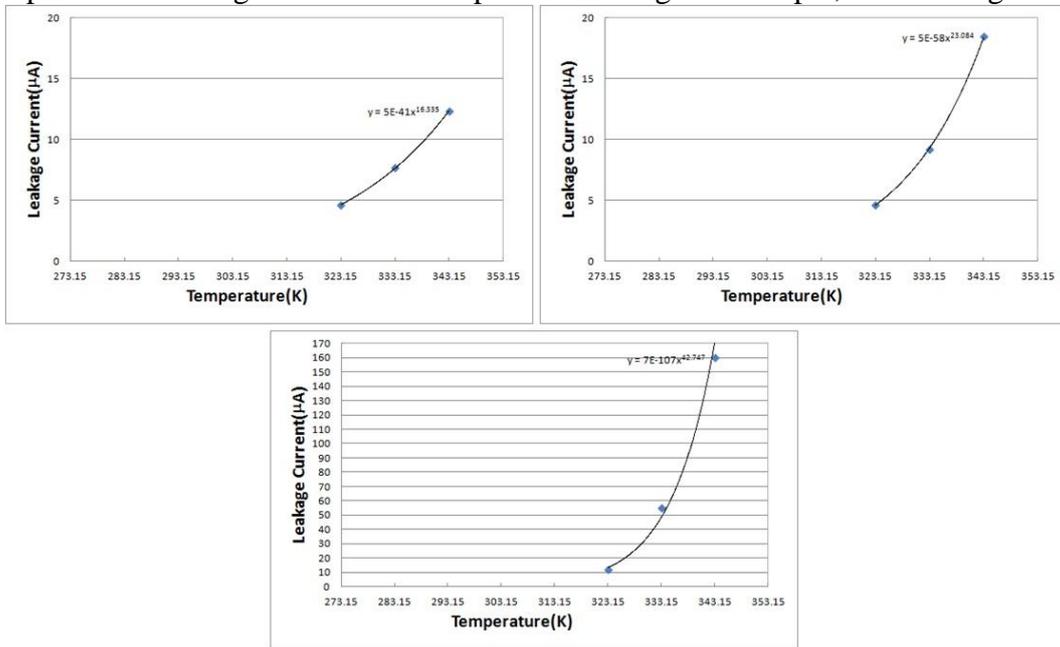


Fig.5 The relationship between leakage current and temperature through the sample when the experiment work times to 0.25h, 0.5h and 1h

From the Fig.5, it can be seen that no matter what the time is 0.25h, 0.5h or 1h, the relationship between leakage current and temperature through the PZT sample satisfy the below formula:

$$I_L = \alpha T^\beta \quad (6)$$

The α and β are constant, α order of magnitudes is 10^{-107} — 10^{-41} , the value of β is increasing from 16.335, and the increasing rate is corresponding with temperature, along with the temperature increasing, the leakage current of the samples increased similar. In all, the temperature can attribute to the rate of electrical degradation increasing.

Conclusion

a. The relationship of temperature and the time of the sample's leakage current rising a constant value:

$$t = CT^\gamma I_L^\delta \quad (\gamma < 0, \quad |\gamma| > 1)$$

We can use this formula to compute the lifetime of the PZT while ascertain the leakage current I_L .

b. The relationship of leakage current and temperature is:

$$I_L = \alpha T^\beta (\beta > 1)$$

Acknowledgment:

This work was financially supported by the Training Programs of Innovation and Entrepreneurship for postgraduate. The number of the program is 2014085.

Reference

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